Search Notes



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SEARCHED

Class	Subclass	Date	Examiner
204	450	07.11.2007	CTM
366	341	07.11.2007	CTM
422	100, 101	07.11.2007	CTM
435	287.3	07.11.2007	СТМ
436	052	07.11.2007	CTM
516	073	07.30.2007	CTM

SEARCH NOTES

Search Notes	Date	Examiner
See EAST Search Report	07.10.2007	CTM
See Updated EAST Search Report	07 April 2008	CTM
See Updated EAST Search Report	17 December 2008	СТМ

INTERFERENCE SEARCH

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